Takashi Sekiguchi

List of Publications by Year in descending order

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#	Article	IF	CITATIONS
1	Atomic-scale investigation of implanted Mg in GaN through ultra-high-pressure annealing. Journal of Applied Physics, 2022, 131, .	1.1	8
2	Stable single atomic silver wires assembling into a circuitry-connectable nanoarray. Nature Communications, 2021, 12, 1191.	5.8	19
3	Cathodoluminescence Investigation of Stacking Faults and Dislocations in the Edge Part of Seedâ€Grown <i>m</i> â€Plane GaN Substrate. Physica Status Solidi (A) Applications and Materials Science, 2021, 218, 2100175.	0.8	3
4	Composition dependent properties of p- and n-type polycrystalline group-IV alloy thin films. Journal of Alloys and Compounds, 2021, 887, 161306.	2.8	5
5	Electron-Beam-Induced Current and Cathodoluminescence Study of Dislocations in SrTiO3. Crystals, 2020, 10, 736.	1.0	3
6	Influence of implanted Mg concentration on defects and Mg distribution in GaN. Journal of Applied Physics, 2020, 128, .	1.1	16
7	Mg diffusion and activation along threading dislocations in GaN. Applied Physics Letters, 2020, 116, .	1.5	12
8	Electron-Beam-Induced Current Study of Dislocations and Leakage Sites in GaN Schottky Barrier Diodes. Journal of Electronic Materials, 2020, 49, 5196-5204.	1.0	3
9	Analysis on the Shapes of the Shockley type Stacking Faults Generated by the REDG Effect in the 4H-SiC Power Devices. Nihon Kessho Gakkaishi, 2020, 62, 150-157.	0.0	0
10	Cathodoluminescence and scanning transmission electron microscopy study of InGaN/GaN quantum wells in core-shell GaN nanowires. Applied Physics Express, 2019, 12, 085003.	1.1	12
11	Oxygen vacancy migration along dislocations in SrTiO ₃ studied by cathodoluminescence. Journal Physics D: Applied Physics, 2019, 52, 475103.	1.3	12
12	Wafer-scale analysis of GaN substrate wafer by imaging cathodoluminescence. Applied Physics Express, 2019, 12, 051005.	1.1	5
13	Cathodoluminescene study of Mg implanted GaN: the impact of dislocation on Mg diffusion. Applied Physics Express, 2019, 12, 051010.	1.1	25
14	Energy and Direction Resolved Secondary Electron Imaging Using Fountain Detector. Journal of Surface Analysis (Online), 2019, 26, 148-149.	0.1	0
15	Morphology of single Shockley-type stacking faults generated by recombination enhanced dislocation glide in 4H–SiC. Philosophical Magazine, 2018, 98, 878-898.	0.7	17
16	Development of SEM/STEM-WDX for highly sensitive detection of light elements. Journal of Instrumentation, 2018, 13, P02025-P02025.	0.5	0
17	Valence band edge tail states and band gap defect levels of GaN bulk and In <i>_x</i> Ga _{1â^'} <i>_x</i> N films detected by hard X-ray photoemission and photothermal deflection spectroscopy. Applied Physics Express, 2018, 11, 021002.	1.1	17
18	Reaction of europium-doped α-SiAlON phosphors with sodium borosilicate glass matrices. Journal of the European Ceramic Society, 2018, 38, 735-741.	2.8	11

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19	Low Energy Secondary Electron Imaging of Nanosheets Using Inverted Fountain Detector. Microscopy and Microanalysis, 2018, 24, 642-643.	0.2	Ο
20	Secondary electron spectroscopy for imaging semiconductor materials. , 2018, , .		0
21	Investigation of Si Dendrites by Electron-Beam-Induced Current. Crystals, 2018, 8, 317.	1.0	1
22	Development of a fountain detector for spectroscopy of secondary electrons in scanning electron microscopy. Japanese Journal of Applied Physics, 2018, 57, 046701.	0.8	4
23	Collection efficiency and acceptance maps of electron detectors for understanding signal detection on modern scanning electron microscopy. Microscopy (Oxford, England), 2018, 67, 18-29.	0.7	6
24	Surface defects generated by intrinsic origins on 4H-SiC epitaxial wafers observed by scanning electron microscopy. Microscopy (Oxford, England), 2017, 66, 95-102.	0.7	5
25	Numerical analysis of the relation between dislocation density and residual strain in silicon ingots used in solar cells. Journal of Crystal Growth, 2017, 474, 130-134.	0.7	9
26	Investigation of V-shaped extended defects in a 4H–SiC epitaxial film. Philosophical Magazine, 2017, 97, 657-670.	0.7	5
27	Deep-level defects related to the emissive pits in thick InGaN films on GaN template and bulk substrates. APL Materials, 2017, 5, .	2.2	14
28	Enhanced cathodoluminescence of green β-sialon:Eu2+ phosphor by In2O3 coating. Journal of Alloys and Compounds, 2017, 727, 1110-1114.	2.8	8
29	Initial leakage current paths in the vertical-type GaN-on-GaN Schottky barrier diodes. Applied Physics Letters, 2017, 111, .	1.5	55
30	Development of a Fountain Detector for Spectroscopy of Secondary Electrons in SEM. Microscopy and Microanalysis, 2017, 23, 590-591.	0.2	1
31	Transition of Emission Colours as a Consequence of Heat-Treatment of Carbon Coated Ce3+-Doped YAG Phosphors. Materials, 2017, 10, 1180.	1.3	10
32	Cathodoluminescence study of killer defects in GaN wafers on sapphire substrates. Physica Status Solidi C: Current Topics in Solid State Physics, 2017, 14, 1700054.	0.8	3
33	Development of fountain detectors for spectroscopy of secondary electron in SEM. Physica Status Solidi C: Current Topics in Solid State Physics, 2017, 14, 1700057.	0.8	3
34	Cathodoluminescnece study of pnâ€junctions in widegap materials using cross sectional polishing. Physica Status Solidi C: Current Topics in Solid State Physics, 2017, 14, 1700096.	0.8	0
35	Temperature-dependent recombination velocity analysis on artificial small angle grain boundaries using electron beam induced current method. Journal of Applied Physics, 2016, 119, 065302.	1.1	1
36	Dislocation behavior in seedâ€cast grown Si ingots based on crystallographic orientation. Progress in Photovoltaics: Research and Applications, 2016, 24, 1513-1522.	4.4	10

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37	High homogeneity, thermal stability and external quantum efficiency of Ce:YAG single-crystal powder phosphors for white LEDs. Journal of the Ceramic Society of Japan, 2016, 124, 574-578.	0.5	5
38	Prevention of thermal- and moisture-induced degradation of the photoluminescence properties of the Sr ₂ Si ₅ N ₈ :Eu ²⁺ red phosphor by thermal post-treatment in N ₂ –H ₂ . Physical Chemistry Chemical Physics, 2016, 18, 12494-12504.	1.3	36
39	Ternary In2S3/In2O3 heterostructures and their cathodoluminescence. RSC Advances, 2016, 6, 51089-51095.	1.7	4
40	Investigation of dislocations in Nb-doped (100) SrTiO3 single crystals and their impacts on resistive switching. Superlattices and Microstructures, 2016, 99, 182-185.	1.4	5
41	Effect of Σ3 generation on random grain boundaries in multicrystalline silicon. Superlattices and Microstructures, 2016, 99, 136-139.	1.4	3
42	SEM observation of p-n junction in semiconductors using fountain secondary electron detector. Superlattices and Microstructures, 2016, 99, 165-168.	1.4	4
43	Analysis of Dislocation Structures in 4Hâ€SiC by Synchrotron Xâ€Ray Topography. Electrical Engineering in Japan (English Translation of Denki Gakkai Ronbunshi), 2016, 197, 3-17.	0.2	7
44	CaAlSiN ₃ :Eu ²⁺ translucent ceramic: a promising robust and efficient red color converter for solid state laser displays and lighting. Journal of Materials Chemistry C, 2016, 4, 8197-8205.	2.7	115
45	Low-energy Cathodoluminescence for (Oxy)Nitride Phosphors. Journal of Visualized Experiments, 2016, , .	0.2	2
46	Surface defects generated by extrinsic origins on 4H-SiC epitaxial-wafers observed by scanning electron microscopy. Microscopy (Oxford, England), 2016, 66, 103-109.	0.7	4
47	Imaging and spectroscopy of secondary electrons from AIN and β-SiAlON ceramics using fountain detector. Superlattices and Microstructures, 2016, 99, 41-44.	1.4	1
48	Cathodoluminescence study on the impurity behaviors at threading dislocations in GaN. Superlattices and Microstructures, 2016, 99, 77-82.	1.4	6
49	Solubility and crystallographic facet tailoring of (GaN) _{1â^'x} (ZnO) _x pseudobinary solid-solution nanostructures as promising photocatalysts. Nanoscale, 2016, 8, 3694-3703.	2.8	42
50	Arbitrary cross-section SEM-cathodoluminescence imaging of growth sectors and local carrier concentrations within micro-sampled semiconductor nanorods. Nature Communications, 2016, 7, 10609.	5.8	13
51	Defects and luminescence control of AlN ceramic by Si-doping. Scripta Materialia, 2016, 110, 109-112.	2.6	12
52	Cross-sectional electric field distributions in BaSi2 homo and BaSi2/Si hetero pn junctions. , 2015, , .		1
53	B13-O-10Low Energy Secondary Electron Imaging for Various Semiconductors using Fountain Detector. Microscopy (Oxford, England), 2015, 64, i36.1-i36.	0.7	0
54	Single-Seed Casting Large-Size Monocrystalline Silicon for High-Efficiency and Low-Cost Solar Cells. Engineering, 2015, 1, 378-383.	3.2	7

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55	Defect Characterization in Silicon by Electron-Beam-Induced Current and Cathodoluminescence Techniques. Lecture Notes in Physics, 2015, , 343-373.	0.3	3
56	Influence of dislocations on indium diffusion in semi-polar InGaN/GaN heterostructures. AIP Advances, 2015, 5, .	0.6	4
57	Enhanced Light Emission due to Formation of Semi-polar InGaN/GaN Multi-quantum Wells. Nanoscale Research Letters, 2015, 10, 459.	3.1	1
58	Control of extended defects in cast multicrystalline silicon using polycrystalline template. Physica Status Solidi C: Current Topics in Solid State Physics, 2015, 12, 1099-1102.	0.8	1
59	Spontaneous Ga incorporation in ZnO nanowires epitaxially grown on GaN substrate. Physica Status Solidi - Rapid Research Letters, 2015, 9, 466-469.	1.2	5
60	Control of extended defects in cast and seed cast Si ingots for photovoltaic application. Physica Status Solidi C: Current Topics in Solid State Physics, 2015, 12, 1094-1098.	0.8	0
61	Cathodoluminescence study of optical properties along the growth direction of ZnO films on GaN substrate. Physica Status Solidi C: Current Topics in Solid State Physics, 2015, 12, 1129-1131.	0.8	1
62	Now, Scanning Electron Microscope is Attracting Much Attention of Researchers. Hyomen Kagaku, 2015, 36, 157-157.	0.0	0
63	Moisture-induced degradation and its mechanism of (Sr,Ca)AlSiN ₃ :Eu ²⁺ , a red-color-converter for solid state lighting. Journal of Materials Chemistry C, 2015, 3, 3181-3188.	2.7	75
64	Strong Energy-Transfer-Induced Enhancement of Luminescence Efficiency of Eu ²⁺ - and Mn ²⁺ -Codoped Gamma-AlON for Near-UV-LED-Pumped Solid State Lighting. Inorganic Chemistry, 2015, 54, 5556-5565.	1.9	51
65	Advantage in solar cell efficiency of high-quality seed cast mono Si ingot. Applied Physics Express, 2015, 8, 062301.	1.1	17
66	Helical Growth of Aluminum Nitride: New Insights into Its Growth Habit from Nanostructures to Single Crystals. Scientific Reports, 2015, 5, 10087.	1.6	18
67	Orientation Dependency of Dislocation Generation in Si Growth Process. Solid State Phenomena, 2015, 242, 15-20.	0.3	1
68	Threading dislocation reduction in a GaN film with a buffer layer grown at an intermediate temperature. Journal of the Korean Physical Society, 2015, 66, 214-218.	0.3	0
69	Characterization of comet-shaped defects on C-face 4H-SiC epitaxial wafers by electron microscopy. Journal of Crystal Growth, 2015, 416, 142-147.	0.7	14
70	Band-Gap Deformation Potential and Elasticity Limit of Semiconductor Free-Standing Nanorods Characterized <i>in Situ</i> by Scanning Electron Microscope–Cathodoluminescence Nanospectroscopy. ACS Nano, 2015, 9, 2989-3001.	7.3	22
71	Microanalysis of Calcium Codoped LaAl(Si _{6â^'<i>z</i>} Al _{<i>z</i>})(N _{10â^'<i>z</i>} O _{<i>z</i>}) (<i>z</i> -1): Ce ³⁺ Blue Phosphor. Journal of the American Ceramic Society, 2015, 98, 1253-1258.	1.9	4
72	Grain boundary interactions in multicrystalline silicon grown from small randomly oriented seeds. Applied Physics Express, 2015, 8, 035502.	1.1	24

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73	Cross-sectional potential profile across a BaSi2pn junction by Kelvin probe force microscopy. Japanese Journal of Applied Physics, 2015, 54, 030306.	0.8	5
74	Reduced thermal degradation of the red-emitting Sr ₂ Si ₅ N ₈ :Eu ²⁺ phosphor via thermal treatment in nitrogen. Journal of Materials Chemistry C, 2015, 3, 7642-7651.	2.7	60
75	Pseudobinary Solidâ€&olution: An Alternative Way for the Bandgap Engineering of Semiconductor Nanowires in the Case of GaP–ZnSe. Advanced Functional Materials, 2015, 25, 2543-2551.	7.8	31
76	Investigation of dislocations in Nb-doped SrTiO3 by electron-beam-induced current and transmission electron microscopy. Applied Physics Letters, 2015, 106, 102109.	1.5	10
77	Low-pass secondary electron detector for outlens scanning electron microscopy. Japanese Journal of Applied Physics, 2015, 54, 088001.	0.8	10
78	Origin of recombination activity at small angle grain boundaries in multicrystalline silicon using multi-seed casting growth method. Japanese Journal of Applied Physics, 2015, 54, 08KD16.	0.8	2
79	Synthesis and Crystal Structures of BaLaSi ₂ with cis–trans Si Chains and Ba ₅ LaSi ₆ with Pentagonal Si Rings. Inorganic Chemistry, 2015, 54, 9188-9194.	1.9	2
80	Applicability of the three-dimensional Alexander-Haasen model for the analysis of dislocation distributions in single-crystal silicon. Journal of Crystal Growth, 2015, 411, 49-55.	0.7	11
81	Cathodoluminescence and Photoconductive Characteristics of Singleâ€Crystal Ternary CdS/CdSe/CdS Biaxial Nanobelts. Small, 2015, 11, 1531-1536.	5.2	14
82	Analysis of Dislocation Structures in 4H-SiC by Synchrotron X-ray Topography. IEEJ Transactions on Fundamentals and Materials, 2015, 135, 768-779.	0.2	1
83	Grain boundaries characterization of semiconducting BaSi <inf>2</inf> thin films on a polycrystalline Si substrate. , 2014, , .		0
84	Potential variation around grain boundaries in BaSi2 films grown on multicrystalline silicon evaluated using Kelvin probe force microscopy. Journal of Applied Physics, 2014, 116, .	1.1	8
85	A Multilevel Intermediateâ€Band Solar Cell by InGaN/GaN Quantum Dots with a Strainâ€Modulated Structure. Advanced Materials, 2014, 26, 1414-1420.	11.1	40
86	In situ monitoring of stacking fault formation and its carrier lifetime mediation in p-type 4H-SiC. Applied Physics Letters, 2014, 105, 042104.	1.5	9
87	Comparison of slicing-induced damage in hexagonal SiC by wire sawing with loose abrasive, wire sawing with fixed abrasive, and electric discharge machining. Japanese Journal of Applied Physics, 2014, 53, 071301.	0.8	19
88	Effect of Fe impurity on the dislocations in 4H-SiC: Insights from electrical and optical characterization. Japanese Journal of Applied Physics, 2014, 53, 05FG01.	0.8	2
89	Grain growth of cast-multicrystalline silicon grown from small randomly oriented seed crystal. Journal of Crystal Growth, 2014, 401, 717-719.	0.7	30
90	Crystal growth of 50 cm square mono-like Si by directional solidification and its characterization. Journal of Crystal Growth, 2014, 401, 133-136.	0.7	25

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91	Synthesis and cathodoluminescence of Sb/P co-doped GaN nanowires. Journal of Luminescence, 2014, 145, 208-212.	1.5	6
92	Si-based new material for high-efficiency thin film solar cells. , 2014, , .		0
93	Cathodoluminescence Properties of Blue Emitting <scp><scp>Eu</scp></scp> ²⁺ â€Doped <scp><scp>AlN</scp></scp> â€Polytypoids for Fieldâ€Emission Displays. Journal of the American Ceramic Society, 2014, 97, 339-341.	1.9	3
94	Influence of Si on the particle growth of AlN ceramics. Applied Physics Express, 2014, 7, 115503.	1.1	6
95	A novel and high brightness AlN:Mn2+ red phosphor for field emission displays. Dalton Transactions, 2014, 43, 6120.	1.6	55
96	Contrast analysis of Shockley partial dislocations in 4H-SiC observed by synchrotron Berg–Barrett X-ray topography. Philosophical Magazine, 2014, 94, 1674-1685.	0.7	35
97	Local defect-induced red-shift of cathodoluminescence in individual ZnS nanobelts. Nanoscale, 2014, 6, 12414-12420.	2.8	21
98	Cross-sectional observation of stacking faults in 4H-SiC by KOH etching on nonpolar \${ 1ar{1}00} \$ face, cathodoluminescence imaging, and transmission electron microscopy. Japanese Journal of Applied Physics, 2014, 53, 081301.	0.8	4
99	Local electrical properties of n-AlInAs/i-GaInAs electron channel structures characterized by theprobe-electron-beam-induced current technique. Microscopy (Oxford, England), 2014, 63, 161-166.	0.7	3
100	Origin of Yellow-Band Emission in Epitaxially Grown GaN Nanowire Arrays. ACS Applied Materials & Interfaces, 2014, 6, 14159-14166.	4.0	57
101	Thermal stress induced dislocation distribution in directional solidification of Si for PV application. Journal of Crystal Growth, 2014, 408, 19-24.	0.7	35
102	Analysis of the electrical properties of Cr/n-BaSi2 Schottky junction and n-BaSi2/p-Si heterojunction diodes for solar cell applications. Journal of Applied Physics, 2014, 115, .	1.1	49
103	Evaluation of minority carrier diffusion length of undoped n-BaSi ₂ epitaxial thin films on Si(001) substrates by electron-beam-induced-current technique. Japanese Journal of Applied Physics, 2014, 53, 078004.	0.8	20
104	Cheap, Gram-Scale Fabrication of BN Nanosheets via Substitution Reaction of Graphite Powders and Their Use for Mechanical Reinforcement of Polymers. Scientific Reports, 2014, 4, 4211.	1.6	39
105	Dislocation Generation and Propagation across the Seed in Seed Cast-Si Ingots. Acta Physica Polonica A, 2014, 125, 1024-1026.	0.2	1
106	Focused Ion Beam Imaging of Defects in Multicrystalline Si for Photovoltaic Application. Acta Physica Polonica A, 2014, 125, 991-993.	0.2	1
107	Luminescence properties of a blue-emitting phosphor: (Sr1â^'xEux)Si9Al19ON31 (0 <xâ‰⊉). journal="" of<br="">Solid State Chemistry, 2013, 207, 49-54.</xâ‰⊉).>	1.4	14

108 Cathodoluminescence of Self-assembled Nanosystems. , 2013, , 557-601.

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109	Evaluation of residual strain in directional solidified monoâ€&i ingots. Physica Status Solidi C: Current Topics in Solid State Physics, 2013, 10, 141-145.	0.8	15
110	Crystallography and cathodoluminescence of pyramid-like GaN nanorods epitaxially grown on a sapphire substrate. RSC Advances, 2013, 3, 22914.	1.7	20
111	Butterfly-shaped distribution of SiN precipitates in multi-crystalline Si for solar cells. Journal of Crystal Growth, 2013, 377, 37-42.	0.7	14
112	Ion irradiation induced formation of CdO microcrystals on CdTe surfaces. Materials Letters, 2013, 92, 397-400.	1.3	7
113	Synthesis, Microstructure, and Cathodoluminescence of [0001]-Oriented GaN Nanorods Grown on Conductive Graphite Substrate. ACS Applied Materials & Interfaces, 2013, 5, 12066-12072.	4.0	33
114	Solid Solution, Phase Separation, and Cathodoluminescence of GaP–ZnS Nanostructures. ACS Applied Materials & Interfaces, 2013, 5, 9199-9204.	4.0	16
115	Growth Temperature Influence on the Luminescence of Eu,Si-Codoped AlN Phosphors. ECS Journal of Solid State Science and Technology, 2013, 2, R126-R130.	0.9	8
116	Local analysis of Eu ²⁺ emission in CaAlSiN ₃ . Science and Technology of Advanced Materials, 2013, 14, 064201.	2.8	18
117	10 cm Diameter Mono Cast Si Growth and its Characterization. Solid State Phenomena, 2013, 205-206, 89-93.	0.3	4
118	Analysis of Inhomogeneous Dislocation Distribution in Multicrystalline Si. Solid State Phenomena, 2013, 205-206, 77-82.	0.3	0
119	Cathodoluminescence Modulation of ZnS Nanostructures by Morphology, Doping, and Temperature. Advanced Functional Materials, 2013, 23, 3701-3709.	7.8	69
120	Evaluation of potential variations around grain boundaries in BaSi2 epitaxial films by Kelvin probe force microscopy. Applied Physics Letters, 2013, 103, .	1.5	29
121	Effect of Crystallinity on Residual Strain Distribution in Cast-Grown Si. Japanese Journal of Applied Physics, 2013, 52, 065501.	0.8	11
122	Triangular ZnO Nanosheets: Synthesis, Crystallography and Cathodoluminescence. Journal of Nanoscience and Nanotechnology, 2013, 13, 5744-5749.	0.9	7
123	Emission Enhancement of SiC/SiO ₂ Core/Shell Nanowires Induced by the Oxide Shell. Materials Science Forum, 2012, 717-720, 557-560.	0.3	1
124	Cathodoluminescence study of nonuniformity in hydride vapor phase epitaxy-grown thick GaN films. Journal of Electron Microscopy, 2012, 61, 25-30.	0.9	8
125	Tuning minority-carrier lifetime through stacking fault defects: The case of polytypic SiC. Applied Physics Letters, 2012, 100, .	1.5	20
126	Analysis of the spectra of trivalent erbium in multiple sites of hexagonal aluminum nitride. Optical Materials Express, 2012, 2, 1186.	1.6	6

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127	Influence of substrate nitridation on GaN and InN growth by plasma-assisted molecular-beam epitaxy. Journal of the Ceramic Society of Japan, 2012, 120, 513-519.	O.5	3
128	Characterization of Impurity Doping and Stress in Si/Ge and Ge/Si Core–Shell Nanowires. ACS Nano, 2012, 6, 8887-8895.	7.3	64
129	High-yield boron nitride nanosheets from †chemical blowing': towards practical applications in polymer composites. Journal of Physics Condensed Matter, 2012, 24, 314205.	0.7	40
130	Impact of Light-Element Impurities on Crystalline Defect Generation in Silicon Wafer. Japanese Journal of Applied Physics, 2012, 51, 02BP08.	0.8	7
131	Reduction of polycrystalline grains region near the crucible wall during seeded growth of monocrystalline silicon in a unidirectional solidification furnace. Journal of Crystal Growth, 2012, 352, 47-52.	0.7	55
132	Investigation of grain boundaries in BaSi2 epitaxial films on Si(1 1 1) substrates using transmission electron microscopy and electron-beam-induced current technique. Journal of Crystal Growth, 2012, 348, 75-79.	0.7	133
133	Cross sectional CL study of the growth and annihilation of pit type defects in HVPE grown (0001) thick GaN. Journal of Crystal Growth, 2012, 351, 83-87.	0.7	23
134	Fabrication, characterization, cathodoluminescence, and field-emission properties of silica (SiO2) nanostructures. Materials Characterization, 2012, 73, 81-88.	1.9	4
135	Evaluation of defects generation in crystalline silicon ingot grown by cast technique with seed crystal for solar cells. Journal of Applied Physics, 2012, 111, 074505.	1.1	24
136	Facile synthesis of vertically aligned hexagonal boron nitride nanosheets hybridized with graphitic domains. Journal of Materials Chemistry, 2012, 22, 4818.	6.7	81
137	Dislocation Analysis of a New Method for Growing Large-Size Crystals of Monocrystalline Silicon Using a Seed Casting Technique. Crystal Growth and Design, 2012, 12, 6144-6150.	1.4	17
138	Anisotropic Thermal Stress Simulation with Complex Crystal–Melt Interface Evolution for Seeded Growth of Monocrystalline Silicon. Crystal Growth and Design, 2012, 12, 5708-5714.	1.4	16
139	Direct imaging and optical activities of stacking faults in 4H-SiC homoepitaxial films. Journal of Applied Physics, 2012, 111, 053513.	1.1	9
140	Secondary electron image formation of a freestanding α-Si3N4nanobelt. Journal of Applied Physics, 2012, 111, 054316.	1.1	3
141	Deep-level photoluminescence due to dislocations and oxygen precipitates in multicrystalline Si. Journal of Applied Physics, 2012, 111, .	1.1	77
142	Surface defects and accompanying imperfections in 4H–SiC: Optical, structural and electrical characterization. Acta Materialia, 2012, 60, 51-58.	3.8	50
143	Luminescence properties of SiC/SiO2 core–shell nanowires with different radial structure. Materials Letters, 2012, 71, 137-140.	1.3	34
144	Impact of Light-Element Impurities on Crystalline Defect Generation in Silicon Wafer. Japanese Journal of Applied Physics, 2012, 51, 02BP08.	0.8	9

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145	Spatially resolved cathodoluminescence of individual BN-coated CaS:Eu nanowires. Nanoscale, 2011, 3, 598-602.	2.8	6
146	Bulk synthesis, growth mechanism and properties of highly pure ultrafine boron nitride nanotubes with diameters of sub-10 nm. Nanotechnology, 2011, 22, 145602.	1.3	97
147	Segregation Behaviors and Radial Distribution of Dopant Atoms in Silicon Nanowires. Nano Letters, 2011, 11, 651-656.	4.5	72
148	Tantalum oxide nanomesh as self-standing one nanometre thick electrolyte. Energy and Environmental Science, 2011, 4, 3509.	15.6	64
149	Crystal growth and characterization of gallium oxynitride nanowires grown on seed crystals. Journal of Crystal Growth, 2011, 337, 87-92.	0.7	8
150	Image instability during the electrical measurement in scanning electron microscope. Physica Status Solidi C: Current Topics in Solid State Physics, 2011, 8, 1407-1411.	0.8	0
151	Comparison of dislocation behavior in Si―and Câ€face 4Hâ€SiC. Physica Status Solidi C: Current Topics in Solid State Physics, 2011, 8, 1278-1281.	0.8	3
152	Secondary electron imaging of titania thin film for surface potential analysis. Physica Status Solidi C: Current Topics in Solid State Physics, 2011, 8, 1293-1296.	0.8	1
153	Electrical and optical activities of small angle grain boundaries in multicrystalline Si. Physica Status Solidi C: Current Topics in Solid State Physics, 2011, 8, 1347-1350.	0.8	4
154	Luminescent properties of ZnO thin films treated by pulse-modulated high-power inductively coupled plasma. Applied Surface Science, 2011, 257, 7156-7159.	3.1	1
155	Spatial luminescent properties and growth mechanism of one- and two-dimensional ZnO complexes. Journal of Luminescence, 2011, 131, 1082-1085.	1.5	3
156	Effect of Introducing β-FeSi2Template Layers on Defect Density and Minority Carrier Diffusion Length in Si Region near p-β-FeSi2/n-Si Heterointerface. Japanese Journal of Applied Physics, 2011, 50, 041303.	0.8	0
157	Minority-carrier diffusion length, minority-carrier lifetime, and photoresponsivity of Î ² -FeSi2 layers grown by molecular-beam epitaxy. Journal of Applied Physics, 2011, 109, 123502.	1.1	11
158	Effect of Introducing β-FeSi ₂ Template Layers on Defect Density and Minority Carrier Diffusion Length in Si Region near p-β-FeSi ₂ /n-Si Heterointerface. Japanese Journal of Applied Physics, 2011, 50, 041303.	0.8	0
159	Investigation on buffer layer for InN growth by molecular beam epitaxy. Journal of the Ceramic Society of Japan, 2010, 118, 152-156.	0.5	1
160	Effects of Chemical Treatment on the Luminescence of ZnO. Journal of Electronic Materials, 2010, 39, 761-765.	1.0	4
161	Quantitative Photoelastic Characterization of Residual Strains in Grains of Multicrystalline Silicon. Journal of Electronic Materials, 2010, 39, 700-703.	1.0	16
162	Electrical and Optical Properties of Stacking Faults in 4H-SiC Devices. Journal of Electronic Materials, 2010, 39, 684-687.	1.0	14

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163	Effect of Size-Dependent Thermal Instability on Synthesis of Zn2SiO4-SiO x Core–Shell Nanotube Arrays and Their Cathodoluminescence Properties. Nanoscale Research Letters, 2010, 5, 773-780.	3.1	19
164	ZnS Branched Architectures as Optoelectronic Devices and Field Emitters. Advanced Materials, 2010, 22, 2376-2380.	11.1	96
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